

**FCC ID: 2AZWI-3595LEQI**

Portable device

According to §15.247(e)(i) and §1.1307(b)(1), systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the Commission's guidelines.

According to KDB447498 D01 General RF Exposure Guidance V06

The 1-g SAR and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances  $\leq 50$  mm are determined by:

$[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot \sqrt{f(\text{GHz})} \leq 3.0$  for 1-g SAR and  $\leq 7.5$  for 10-g extremity SAR, where:

- $f(\text{GHz})$  is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison

When the minimum test separation distance is  $< 5$  mm, a distance of 5 mm is applied to determine SAR test exclusion.

Antenna Type: PCB Antenna

Antenna Gain: 0 dBi

BLE(1M)

Modulation	Channel Freq. (GHz)	Conduct ed power (dBm)	Conducte d power (mW)	Tune-up power (dBm)	Max tune-up power (dBm)	Max tune-up power (mW)	Distance (mm)	Result calculatio n	1g SAR Exclusion threshold	SAR test exclusion
GFSK	2.402	-0.766	0.838	-1.5±1	-0.5	0.891	<5	0.27626	3.00	YES
	2.440	-2.24	0.597	-1.5±1	-0.5	0.891	<5	0.27844	3.00	YES
	2.480	-0.619	0.867	-1.5±1	-0.5	0.891	<5	0.28071	3.00	YES

BLE(2M)

Modulation	Channel Freq. (GHz)	Conduct ed power (dBm)	Conducte d power (mW)	Tune-up power (dBm)	Max tune-up power (dBm)	Max tune-up power (mW)	Distance (mm)	Result calculatio n	1g SAR Exclusion threshold	SAR test exclusion
GFSK	2.402	-1.339	0.735	-1±1	0.0	1.000	<5	0.30997	3.00	YES
	2.440	-0.118	0.973	-1±1	0.0	1.000	<5	0.31241	3.00	YES
	2.480	-1.343	0.734	-1±1	0.0	1.000	<5	0.31496	3.00	YES

**Conclusion:**

For the max result :  $0.31496 \leq 3.0$  for 1-g SAR, No SAR is required.



**Signature:**

**Date:** 2021-12-06

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